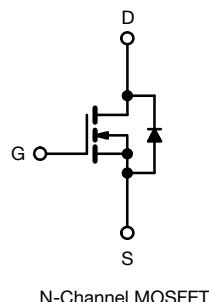
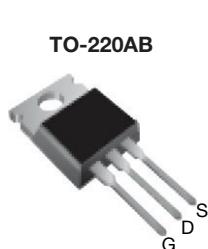


Power MOSFET



PRODUCT SUMMARY

V_{DS} (V)	100	
$R_{DS(on)}$ (Ω)	$V_{GS} = 10$ V	0.54
Q_g max. (nC)	8.3	
Q_{gs} (nC)	2.3	
Q_{gd} (nC)	3.8	
Configuration	Single	

FEATURES

- Dynamic dv/dt rating
- Repetitive avalanche rated
- 175 °C operating temperature
- Fast switching
- Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS*
Available
HALOGEN FREE
Available

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION INFORMATION

Package	TO-220AB
Lead (Pb)-free	IRF510PbF
Lead (Pb)-free and halogen-free	IRF510PbF-BE3

ABSOLUTE MAXIMUM RATINGS ($T_C = 25$ °C, unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-source voltage	V_{DS}	100	V
Gate-source voltage		± 20	
Continuous drain current	I_D	5.6	A
		4.0	
Pulsed drain current ^a	I_{DM}	20	
Linear derating factor		0.29	W/°C
Single pulse avalanche energy ^b	E_{AS}	75	mJ
Repetitive avalanche current ^a	I_{AR}	5.6	A
Repetitive avalanche energy ^a	E_{AR}	4.3	mJ
Maximum power dissipation	P_D	43	W
Peak diode recovery dv/dt ^c	dv/dt	5.5	V/ns
Operating junction and storage temperature range	T_J, T_{stg}	-55 to +175	°C
Soldering recommendations (peak temperature) ^d	For 10 s	300	
Mounting torque	6-32 or M3 screw	10	lbf · in
		1.1	N · m

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. $V_{DD} = 25$ V, starting $T_J = 25$ °C, $L = 4.8$ mH, $R_g = 25 \Omega$, $I_{AS} = 5.6$ A (see fig. 12)

c. $I_{SD} \leq 5.6$ A, $dI/dt \leq 75$ A/μs, $V_{DD} \leq V_{DS}$, $T_J \leq 175$ °C

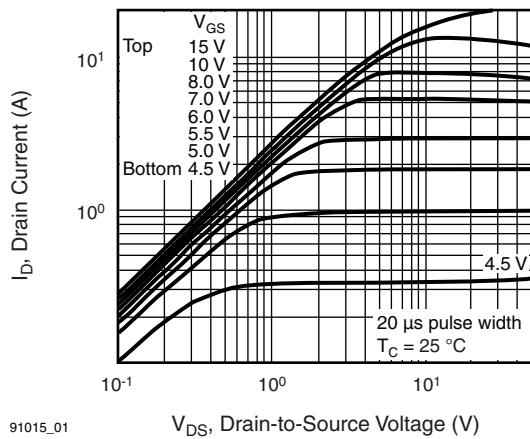
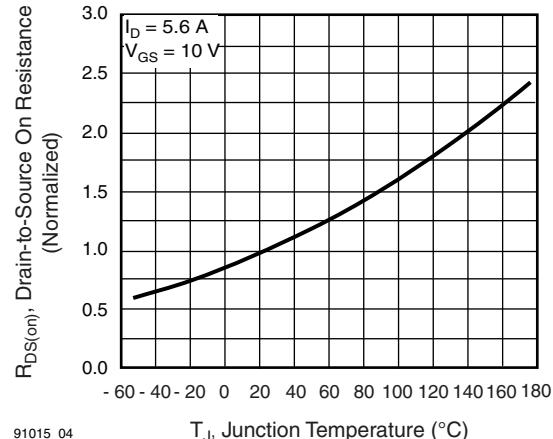
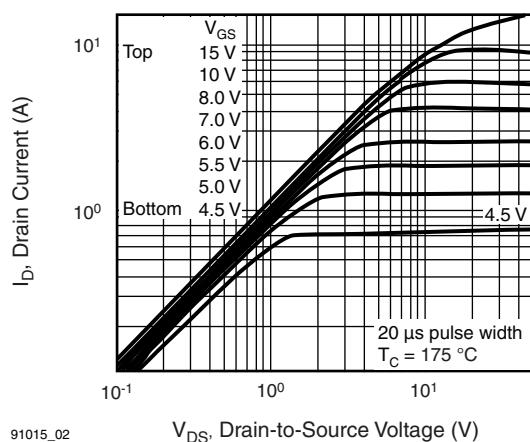
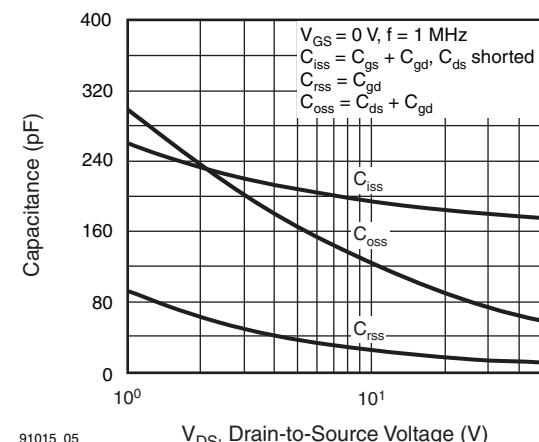
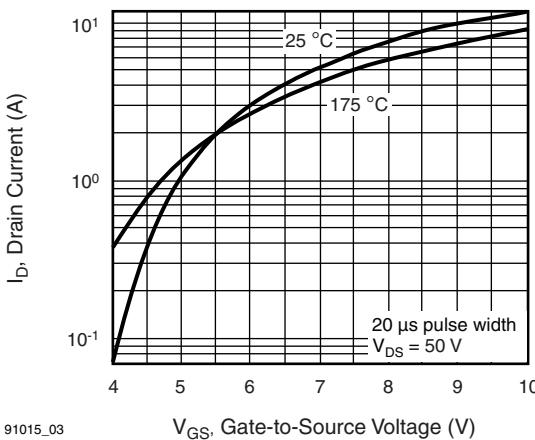
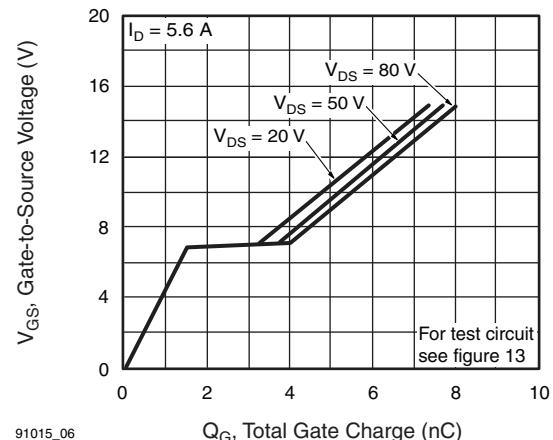
d. 1.6 mm from case

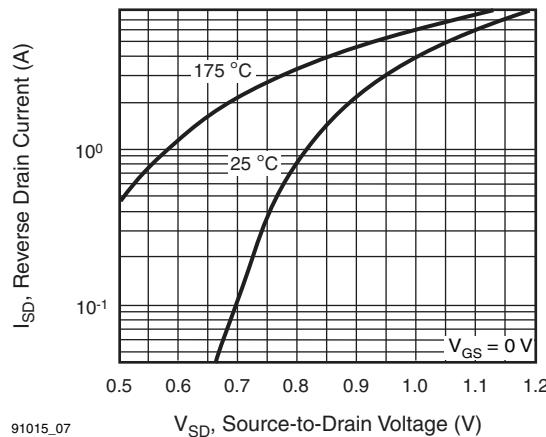
THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R _{thJA}	-	62	°C/W
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	
Maximum junction-to-case (drain)	R _{thJC}	-	3.5	

SPECIFICATIONS ($T_J = 25^\circ\text{C}$, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_J$	Reference to 25°C , $I_D = 1 \text{ mA}$		-	0.12	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		2.0	-	4.0	V
Gate-source leakage	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$		-	-	25	μA
		$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 150^\circ\text{C}$		-	-	250	
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 3.4 A ^b	-	-	0.54	Ω
Forward transconductance	g _{fs}	$V_{DS} = 50 \text{ V}, I_D = 3.4 \text{ A}^b$		1.3	-	-	S
Dynamic							
Input capacitance	C _{iss}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1.0 \text{ MHz}$, see fig. 5		-	180	-	pF
Output capacitance	C _{oss}			-	81	-	
Reverse transfer capacitance	C _{rss}			-	15	-	
Total gate charge	Q _g	V _{GS} = 10 V	I _D = 5.6 A, V _{DS} = 80 V	-	-	8.3	nC
Gate-source charge	Q _{gs}		V _{DS} = 10 V, see fig. 6 and fig. 13 ^b	-	-	2.3	
Gate-drain charge	Q _{gd}		-	-	-	3.8	
Turn-on delay time	t _{d(on)}	$V_{DD} = 50 \text{ V}, I_D = 5.6 \text{ A}$ R _g = 24 Ω, R _D = 8.4 Ω, see fig. 10 ^b		-	6.9	-	ns
Rise time	t _r			-	16	-	
Turn-off delay time	t _{d(off)}			-	15	-	
Fall time	t _f			-	9.4	-	
Gate input resistance	R _g	f = 1 MHz, open drain		2.5	-	11.6	Ω
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH
Internal source inductance	L _S			-	7.5	-	
Drain-Source Body Diode Characteristics							
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p-n junction diode		-	-	5.6	A
Pulsed diode forward current ^a	I _{SM}			-	-	20	
Body diode voltage	V _{SD}	$T_J = 25^\circ\text{C}, I_S = 5.6 \text{ A}, V_{GS} = 0 \text{ V}^b$		-	-	2.5	V
Body diode reverse recovery time	t _{rr}	$T_J = 25^\circ\text{C}, I_F = 5.6 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	100	200	ns
Body diode reverse recovery charge	Q _{rr}			-	0.44	0.88	μC
Forward turn-on time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					

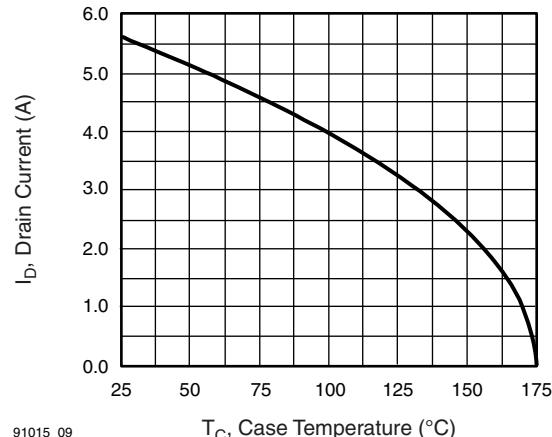
Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %

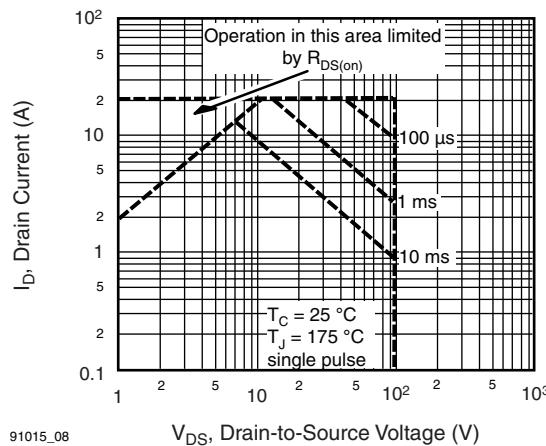
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Fig. 1 - Typical Output Characteristics, $T_C = 25 \text{ }^\circ\text{C}$

Fig. 4 - Normalized On-Resistance vs. Temperature

Fig. 2 - Typical Output Characteristics, $T_C = 175 \text{ }^\circ\text{C}$

Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

Fig. 3 - Typical Transfer Characteristics

Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



91015_07



91015_09 Fig. 9 - Maximum Drain Current vs. Case Temperature



91015_08

Fig. 8 - Maximum Safe Operating Area

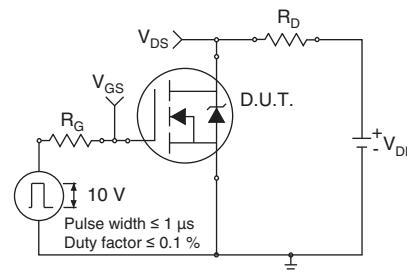


Fig. 10a - Switching Time Test Circuit

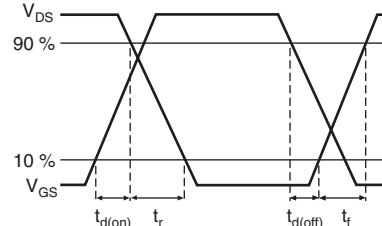
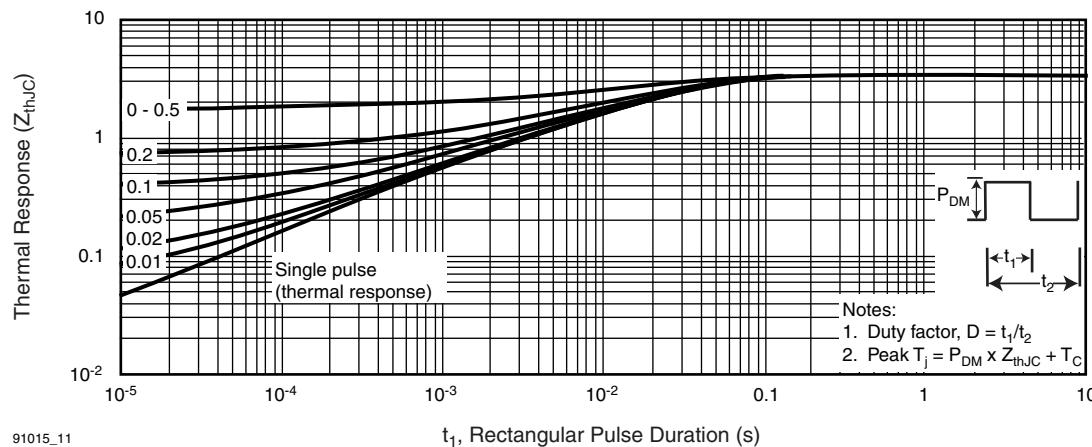


Fig. 10b - Switching Time Waveforms



91015_11

Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

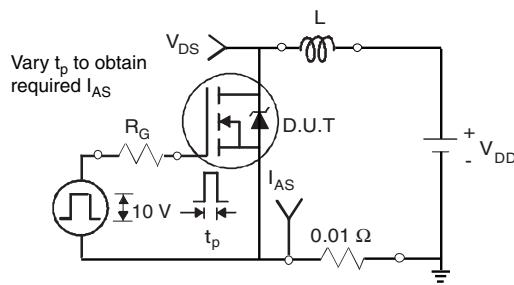


Fig. 12a - Unclamped Inductive Test Circuit

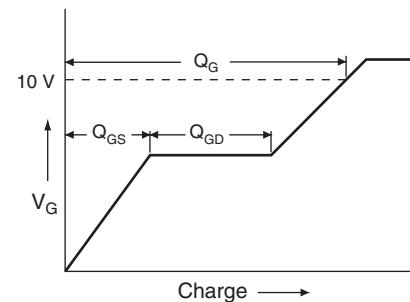


Fig. 13a - Basic Gate Charge Waveform

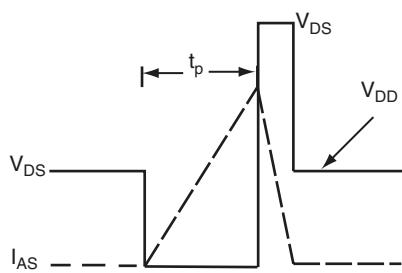


Fig. 12b - Unclamped Inductive Waveforms

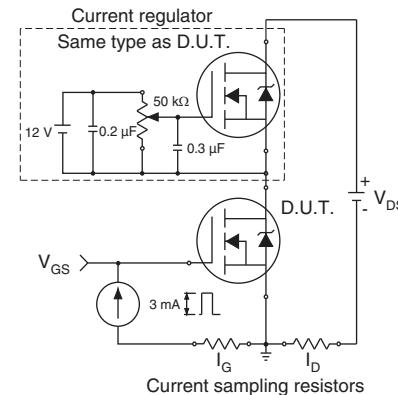


Fig. 13b - Gate Charge Test Circuit

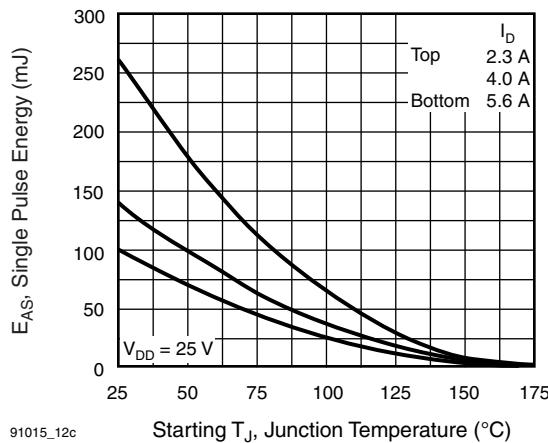


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

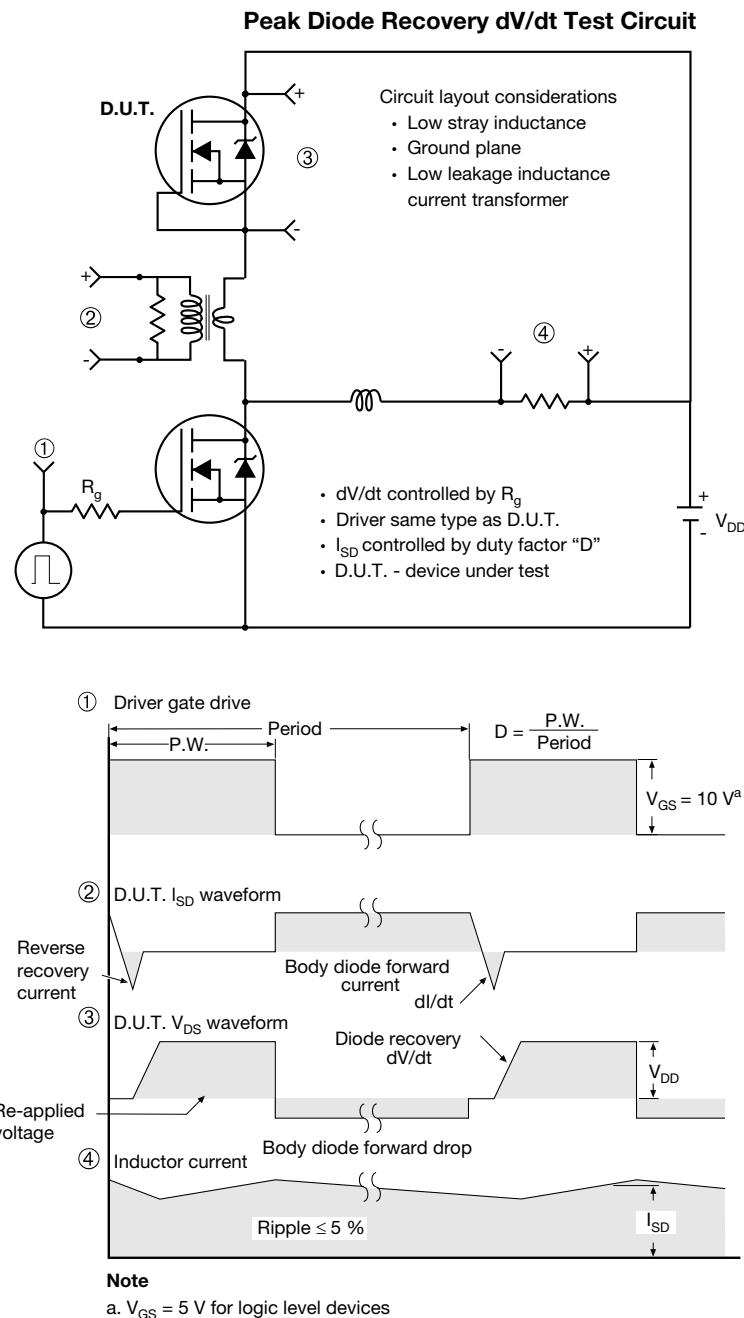


Fig. 14 - For N-Channel

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